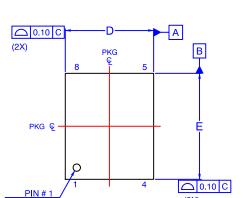


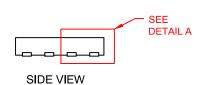
INDICATOR

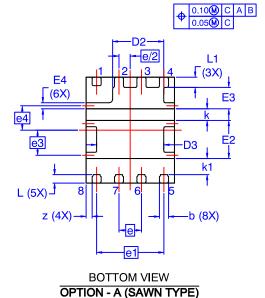
PQFN8 5X6, 1.27P (SAWN TYPE) CASE 483AJ ISSUE A

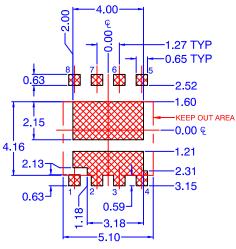
DATE 08 FEB 2021



TOP VIEW

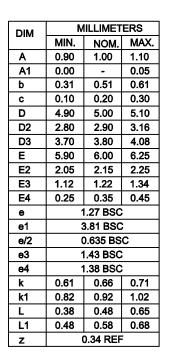






LAND PATTERN RECOMMENDATION FOR SAWN / PUNCHED TYPE

*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.



// 0.10 C	1		
8X A		Ι,	
△ 0.08 C		A1-	C
	DETAIL 'A' (SCALE: 2X)		SEATING PLANE

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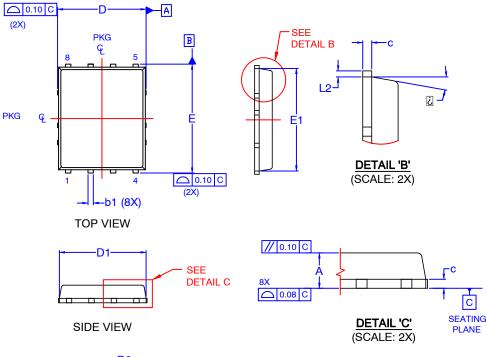
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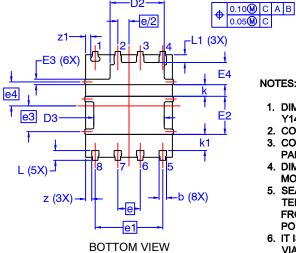
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DIM	MILLIMETERS			
Dilvi	MIN.	NOM.	MAX.	
Α	0.90	1.00	1.10	
b	0.31	0.51	0.61	
b1	0.21	0.31	0.41	
С	0.15	0.25	0.35	
D	4.90	5.00	5.10	
D1	4.80	4.90	5.00	
D2	2.80	3.06	3.16	
D3	3.70	3.98	4.08	
E	5.90	6.00	6.25	
E1	5.70	5.80	5.90	
E2	2.05	2.15	2.25	
E3	0.25	0.33	0.45	
E4	1.12	1.24	1.34	
е	1.27 BSC			
e1	3.81 BSC			
e/2	0.635 BSC			
e3	1.45 BSC			
e4	1.36 BSC			
k	0.61	0.66	0.71	
k1	0.82	0.92	1.02	
L	0.38	0.55	0.65	
L1	0.35	0.45	0.55	
L2	0.08	0.18	0.28	
z	0.34 REF			
z1	0.28 REF			
θ	0°	-	10°	



OPTION - B (PUNCHED TYPE)

NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. COPLANARITY APPLIES TO THE EXPOSED PADS AS WELL AS THE TERMINALS.
- 4. DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.
- 5. SEATING PLANE IS DEFINED BY THE TERMINALS. "A1" IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.
- 6. IT IS RECOMMENDED TO HAVE NO TRACES OR VIAS WITHIN THE KEEP OUT AREA.

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DESCRIPTION:	PQFN8 5X6, 1.27P		PAGE 2 OF 2

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